


<b>Search Notes</b>  	<b>Application/Control No.</b>  09074544	<b>Applicant(s)/Patent Under Reexamination</b>  MEYER ET AL.
	<b>Examiner</b>  Ba Huynh	<b>Art Unit</b>  2179

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
East: USpat search updated	9/19/08	hb

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--